Power MOSFET

30 V, 7.0 A, Single N-Channel, TSOP-6

Features

- Low R_{DS(on)}
- Low Gate Charge
- Pb–Free Package is Available

Applications

- Load Switch
- Notebook PC
- Desktop PC

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Ratin	Symbol	Value	Unit		
Drain-to-Source Voltage	V _{DSS}	30	V		
Gate-to-Source Voltage	V _{GS}	±20	V		
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I _D	5.0	А
Current (Note 1)	State	$T_A = 85^{\circ}C$		3.6	
	t ≤ 10 s	$T_A = 25^{\circ}C$		7.0	
Power Dissipation (Note 1)	ssipation $\begin{array}{c} \text{Steady} \\ \text{State} \end{array}$ $T_A = 25^{\circ}\text{C}$		P _D	1.0	W
	t ≤ 10 s			2.0	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I _D	3.5	А
Current (Note 2)	State	$T_A = 85^{\circ}C$		2.5	
Power Dissipation (Note 2)		$T_A = 25^{\circ}C$	PD	0.5	W
Pulsed Drain Current	t _p =	10 μs	I _{DM}	21	А
Operating Junction and S	T _J , T _{STG}	–55 to 150	°C		
Source Current (Body Dic	۱ _S	2.0	А		
	EAS	54	mJ		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

THERMAL RESISTANCE RATINGS

Rating	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	R_{\thetaJA}	125	°C/W
Junction–to–Ambient – t \leq 10 s (Note 1)	R_{\thetaJA}	62.5	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	248	

1. Surface-mounted on FR4 board using 1 inch sq pad size

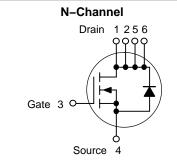
(Cu area = 1.127 in sq [1 oz] including traces). 2. Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.0773 in sq).

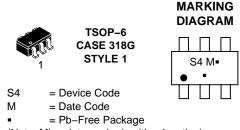


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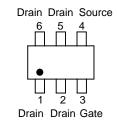
V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX	
30 V	21.5 mΩ @ 10 V	7.0 A	
30 V	30 mΩ @ 4.5 V	7.0 A	





⁽Note: Microdot may be in either location)

PIN ASSIGNMENT



ORDERING INFORMATION

Device	Package	Shipping [†]
NTGS4141NT1	TSOP-6	3000/Tape & Reel
NTGS4141NT1G	TSOP-6 (Pb-Free)	3000/Tape & Reel

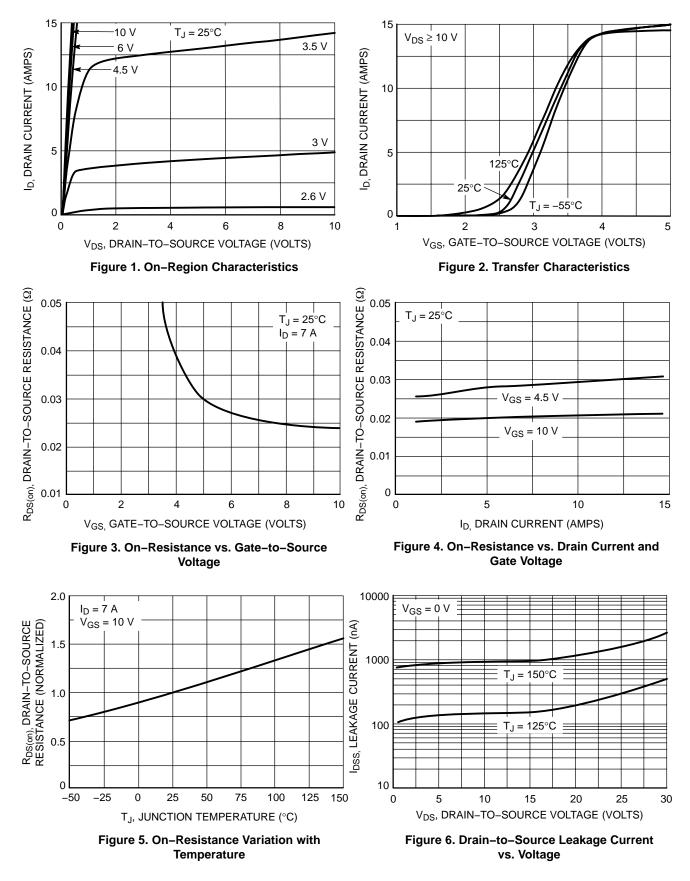
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

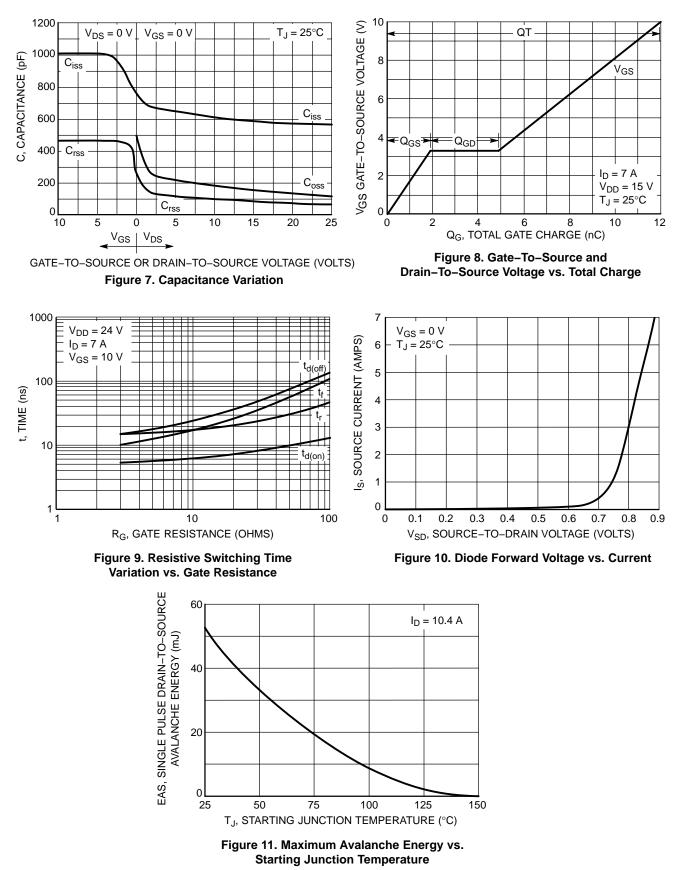
Characteristic	Symbol	Test Condition		Min	Тур	Мах	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				18.4		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_J = 25^{\circ}C$			1.0	μΑ
			$T_J = 125^{\circ}C$			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V ₀	_{GS} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{I}$	_D = 250 μA	1.0		3.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V,	I _D = 7.0 A		21.5	25	mΩ
		V _{GS} = 4.5 V,	I _D = 6.0 A		30	35	
Forward Transconductance	9fs	V _{DS} = 10 V,	I _D = 7.0 A		30		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 24 V			560		pF
Output Capacitance	C _{OSS}				115		1
Reverse Transfer Capacitance	C _{RSS}				75		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 7.0 A			12		nC
Threshold Gate Charge	Q _{G(TH)}				0.85		
Gate-to-Source Charge	Q _{GS}				1.9		
Gate-to-Drain Charge	Q _{GD}				3.0		
Total Gate Charge	Q _{G(TOT)}				6.0		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, \	/ _{DS} = 15 V,		0.8		
Gate-to-Source Charge	Q _{GS}	I _D = 7.	.0Ă		1.85		
Gate-to-Drain Charge	Q _{GD}				3.0		
Gate Resistance	R _G				2.8		Ω
SWITCHING CHARACTERISTICS (Note 4)		-					
Turn-On Delay Time	t _{d(ON)}				6.0		ns
Rise Time	tr	V _{GS} = 10 V, V	/ns = 24 V.		15		
Turn-Off Delay Time	t _{d(OFF)}	I _D = 7.0 A, R	$R_{\rm G} = 3.0 \ \Omega$		18		
Fall Time	t _f				4.0		
DRAIN – SOURCE DIODE CHARACTERIST	ICS	-					
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 2.0 A	$T_J = 25^{\circ}C$		0.78	1.0	V
		15 - 2.0 A	T _J = 125°C		0.63		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V dI _S /dt = 100 A/µs, I _S = 2.0 A			15		ns
Charge Time	t _a				9.0		_
Discharge Time	t _b				6.0	ļ	4
Reverse Recovery Charge	Q _{RR}				8.0		nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

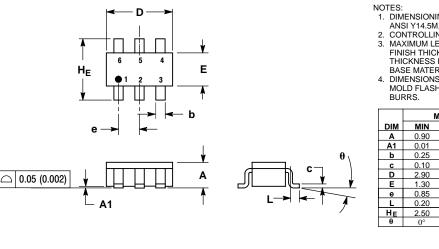






PACKAGE DIMENSIONS

TSOP-6 CASE 318G-02 ISSUE P



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETER.

- CONTROLLING DIMENSION: MILLIMETER.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

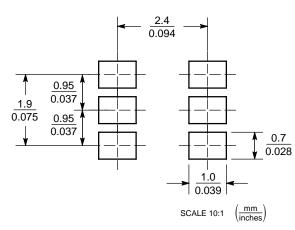
	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.90	1.00	1.10	0.035	0.039	0.043	
A1	0.01	0.06	0.10	0.001	0.002	0.004	
b	0.25	0.38	0.50	0.010	0.014	0.020	
С	0.10	0.18	0.26	0.004	0.007	0.010	
D	2.90	3.00	3.10	0.114	0.118	0.122	
Е	1.30	1.50	1.70	0.051	0.059	0.067	
е	0.85	0.95	1.05	0.034	0.037	0.041	
L	0.20	0.40	0.60	0.008	0.016	0.024	
HE	2.50	2.75	3.00	0.099	0.108	0.118	
θ	0°	-	10°	0°	-	10°	

STYLE 1: PIN 1. DRAIN 2. DRAIN 3. GATE

4. SOURCE 5. DRAIN

6. DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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